

<b>Notice of References Cited</b>	Application/Control No. 09/929,888	Applicant(s)/Patent Under Reexamination NAKANO ET AL.	
	Examiner Alicia Baturay	Art Unit 2155	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,476,825 B1	11-2002	Croy et al.	715/716
	B	US-6,667,992 B1	12-2003	Yanagawa, Yoshifumi	370/490
	C	US-6,148,241 A	11-2000	Ludtke et al.	700/83
	D	US-6,263,503 B1	07-2001	Margulis, Neal	725/81
	E	US-6,449,514 B1	09-2002	Natsubori et al.	700/19
	F	US-6,611,537 B1	08-2003	Edens et al.	370/503
	G	US-6,781,518 B1	08-2004	Hayes et al.	340/825.72
	H	US-6,807,226 B1	10-2004	Suetsugu et al.	375/224
	I	US-2002/0067741 A1	06-2002	Nakano et al.	370/465
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.